ALPHA & OMEGA SEMICONDUCTOR, INC.

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AO7400
N-Channel Enhancement Mode Field Effect Transistor

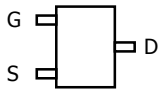
General Description

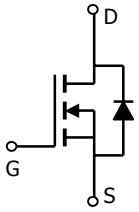
The AO7400 uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 2.5V, in the small SOT323 footprint.

Features

V_{DS} (V) = 30V
I_D = 1.7 A
$R_{DS(ON)}$ < 85mΩ (V_{GS} = 10V)
$R_{DS(ON)}$ < 100mΩ (V_{GS} = 4.5V)
$R_{DS(ON)}$ < 140mΩ (V_{GS} = 2.5V)

SC-70
(SOT-323)
Top View





Absolute Maximum Ratings T_A=25°C unless otherwise noted

Parameter		Symbol	Maximum	Units
Drain-Source Voltage		V_{DS}	30	V
Gate-Source Voltage		V_{GS}	±12	V
Continuous Drain Current [A]	T_A=25°C	I_D	1.7	A
	T_A=70°C		1.3	
Pulsed Drain Current [B]		I_{DM}	15	
Power Dissipation [A]	T_A=25°C	P_D	0.35	W
	T_A=70°C		0.22	
Junction and Storage Temperature Range		T_J, T_{STG}	-55 to 150	°C

Thermal Characteristics

Parameter		Symbol	Typ	Max	Units
Maximum Junction-to-Ambient [A]	t ≤ 10s	$R_{\theta JA}$		360	°C/W
Maximum Junction-to-Ambient [A]	Steady-State		300	425	°C/W
Maximum Junction-to-Lead [C]	Steady-State	$R_{\theta JL}$			°C/W

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV_{DSS}	Drain-Source Breakdown Voltage	I_D=250µA, V_{GS}=0V	30			V
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS}=24V, V_{GS}=0V			1	µA
		T_J=55°C			5	
I_{GSS}	Gate-Body leakage current	V_{DS}=0V, V_{GS}=±12V			100	nA
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS}=V_{GS} I_D=250µA	0.6	1	1.4	V
$I_{D(ON)}$	On state drain current	V_{GS}=4.5V, V_{DS}=5V	10			A
$R_{DS(ON)}$	Static Drain-Source On-Resistance	V_{GS}=10V, I_D=1.5A		70	85	mΩ
		T_J=125°C				
		V_{GS}=4.5V, I_D=1.5A		81	100	mΩ
		V_{GS}=2.5V, I_D=1A		114	140	mΩ
g_{FS}	Forward Transconductance	V_{DS}=5V, I_D=1.5A		6		S
V_{SD}	Diode Forward Voltage	I_S=1A,V_{GS}=0V		0.79	1	V
I_S	Maximum Body-Diode Continuous Current				0.5	A
DYNAMIC PARAMETERS						
C_{iss}	Input Capacitance	V_{GS}=0V, V_{DS}=15V, f=1MHz		390		pF
C_{oss}	Output Capacitance			54.5		pF
C_{rss}	Reverse Transfer Capacitance			41		pF
R_g	Gate resistance	V_{GS}=0V, V_{DS}=0V, f=1MHz		3		Ω
SWITCHING PARAMETERS						
Q_g	Total Gate Charge	V_{GS}=4.5V, V_{DS}=15V, I_D=1.7A		0.62		nC
Q_{gs}	Gate Source Charge			1.58		nC
Q_{gd}	Gate Drain Charge			4.82		nC
$t_{D(on)}$	Turn-On DelayTime	V_{GS}=10V, V_{DS}=15V, R_L=10.0Ω, R_{GEN}=3Ω		2.5		ns
t_r	Turn-On Rise Time			2.3		ns
$t_{D(off)}$	Turn-Off DelayTime			22		ns
t_f	Turn-Off Fall Time			3		ns
t_{rr}	Body Diode Reverse Recovery Time	I_F=1.7A, dI/dt=100A/µs		10		ns
Q_{rr}	Body Diode Reverse Recovery Charge	I_F=1.7A, dI/dt=100A/µs		3.6		nC

A: The value of $R_{\theta JA}$ is measured with the device mounted on 1in^2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C. The value in any a given application depends on the user's specific board design. The current rating is based on the t≤ 10s thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C. The $R_{\theta JA}$ is the sum of the thermal impedence from junction to lead $R_{\theta JL}$ and lead to ambient.

D. The static characteristics in Figures 1 to 6,12,14 are obtained using 80µs pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in^2 FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The SOA curve provides a single pulse rating.